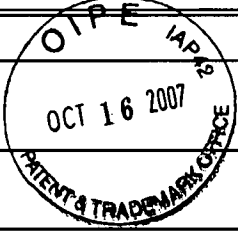


Sheet 1 of 1		INFORMATION DISCLOSURE STATEMENT					
FORM PTO 1449 (<i>modified</i>) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Date Submitted to PTO: October 16, 2007			ATTY DOCKET NO. 2006_1009A		SERIAL NO. 10/584,091		
			APPLICANT Kiminori MIZUUCHI et al.				
			FILING DATE June 22, 2006		GROUP 2828		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	4,882,607	11/1989	Shinada			
	AB	6,649,938	11/2003	Bogatov et al.			
	AC	4,932,034	6/1990	Usami et al.			
	AD						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AE	0 332 453	9/1989	EP			X
	AF	1 063 743	12/2000	EP			X
	AG	58-50790	3/1983	JP			Abstract
	AH						
	AI						
OTHER DOCUMENT(S) (<i>Including Author, Title, Date, Pertinent Pages, Etc.</i>)							
	AJ	European Search Report issued <u>September 5, 2007</u> in European Patent Application EP 04 80 7480.					
	AK	Körbl, M. et al., "Electronic wavelength tuning of multisegment InGaAsP/InP lasers with laterally coupled absorptive DFB gratings", Solid-State Electronics, vol. 47, no. 4 April 2003, pp 741-745.					
	AL	Kuhn, J. et al., "Dynamic Properties of GaInP Multielectrode Ridge-Waveguide Lasers", Semiconductor Science and Technology, vol. 12, no. 4, April 1997, pp. 439-442.					
	AM	Sheng-Hui Yang et al. "Generation of High-Power Picosecond Pulses from a Gain-Switched Two-Section Quantum-Well Laser with a Laterally Tapered Energy-Storing Section", IEEE Photonics Technology Letters, vol. 8, no. 3, March 1996, pp. 337-339.					
	AN	Seltzer, C.P. et al, "The Gain-Lever Effect in InGaAsP/InP Multiple Quantum Well Lasers", Journal of Lightwave Technology" vol.13, no. 2, February 1995, pp. 283-289.					
EXAMINER				DATE CONSIDERED			
/Dung Nguyen/ (03/19/2008)							

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

ALL REFERENCES CONSIDERED EXCEPT WHERE LINED THROUGH. /D.N./